

ATTESTATION of conformity with European Directives

Eclipse Series USB Flash Drive /

Additional Product Name: Nature Series USB Flash Drive;

Voyager Series USB Flash Drive; Outback Series USB Flash Drive;

Pill Series USB Flash Drive; Image Series USB Flash Drive

Reference ES / Additional Model Number: NA; VY; OB; PI; IM Issued to

FLASHBAY ELECTRONICS (SHENZHEN) CO., LTD

3-5/F, Bldg B, Xifengcheng Industrial Park, No.2 Fuyuan Rd,

2nd High-tech Area, Heping, Fuyong, Baoan, Shenzhen 518103,

Guangdong Province, P.R.China

Manufacturer FLASHBAY ELECTRONICS (SHENZHEN) CO., LTD

Technical characteristics 230Va.c. 50Hz

The submitted sample of the above equipment has been tested for CE marking according to following European Directive and following standards:

Electromagnetic directive 2004/108/EC

Standards	Report number	Report date
EN 55022: 2006		
EN 55024: 1998 +A1: 2001 +A2: 2003	(5209)180-0043	2000 1
EN 61000-3-2: 2006	(3209)180-0043	2009 July 8
EN 61000-3-3: 2008		

The referred test report(s) show that the product complies with standard(s) recognized as giving presumption of compliance with the essential requirements in the specified European Directive

This verification does not imply assessment of the production of the product The C€ marking may be affixed if all relevant and effective European Directives with C€ are applicable

HK, 2009 July 8

Product:

Address



Manager, **Electrical Department**

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EMC TEST REPORT

To :	FLASHBAY ELECTRONICS (SHENZHEN) CO., LTD	Fax:	0755-29773574
Attn:	Henry Guo	Email:	henry@flashbay.com
Address :	3-5/F, Bldg B, Xifengcheng Industrial Park, N Fuyong, Baoan, Shenzhen 518103, Guangdo		
Cc :		Fax/Email:	
Attn :			
LCIE Folder No.:	FEC-09JU334ETHS-B	Test date :	2009-06-27 to 2009-07-01

FLASHBAY ELECTRONICS (SHENZHEN) CO., LTD	
3-5/F, Bldg B, Xifengcheng Industrial Pa No.2 Fuyuan Rd, 2 nd High-tech Area, Heping, Fuyong, Baoan, Shenzhen 5181 Guangdong Province, P.R.China	
Eclipse Series USB Flash Drive	
ES	
NA; VY; OB; PI; IM	
230Va.c. 50Hz	
-	
(5209)180-0043	



The submitted sample of the above equipment has been tested according to following European Directive -Electromagnetic directive 2004/108/EC and the tests have been carried out according to the requirements of the following standards:

EN 55022: 2006 & EN 55024: 1998 +A1: 2001 +A2: 2003

EN 61000-3-2: 2006 & EN 61000-3-3: 2008

Comments:

CONCLUSION: The submitted sample was found to COMPLY with the test requirement

Manager, Electrical Department

Name: Steven Tsang Date: July 8, 2009

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BUREAU VERITAS HONG KONG LIMITED

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Testing Program

The tests have been carried out according to the requirements of the following standards:

	Test Standards			
EN 55022: 2006	Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement			
EN 55024: 1998 +A1: 2001 +A2: 2003	Information technology equipment - Immunity characteristics - Limits and methods of measurement			
EN61000-3-2: 2006	Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current ≤ 16A per phase)			
EN61000-3-3: 2008	Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limit - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16A per phase and not subject to conditional connection (equipment input current ≤ 16A per phase)			

Equipment Under Test:

The equipment under test is Eclipse Series USB Flash Drive. Model: ES.

Additional Product Name:

Nature Series USB Flash Drive; Voyager Series USB Flash Drive; Outback Series USB Flash Drive; Pill Series USB Flash Drive; Image Series USB Flash Drive

Additional Model Number:

NA; VY; OB; PI; IM

Additional Model Information:

Declare the Circuit, PCB layout, Electrical parts and Outlook of the products are identical to the basic model. Except the shape and color of the shells.



Test Site(s) & Test Instruments List

Test Site(s)

BUREAU VERITAS HONG KONG LIMITED, EMC CENTRE

No. 2106-2107, 21/F., Westin Centre, 26 Hung To Road, Kwun Tong, Kowloon, Hong Kong

Test Instrument List

Radiated Emission

EQUIPMENT	MANUFACTURER	MODEL NO.	SERIAL NO.
EMI TEST RECEIVER	R&S	ESCI	100379
BILOG ANTENNA	SCHAFFNER	CBL6112D	25229
OPEN AREA TEST SITE	BVCPS	N/A	N/A
ANECHOIC CHAMBER	ALBATROSS	M-CDC	80374004499B
BICONICAL ANTENNA	ROHDE & SCHWARZ	HK116	100179
LOG-PERIODIC DIPOLE ARRAY ANTENNA	ROHDE & SCHWARZ	HL223	832369/001

Conducted Emission

EQUIPMENT	MANUFACTURER	MODEL NO.	SERIAL NO.
EMI TEST RECEIVER	ROHDE & SCHWARZ	ESCS 30	830986/030
LISN	ROHDE & SCHWARZ	ENV216	100024
PULSE LIMITER	ROHDE & SCHWARZ	ESH3 Z2	100088

Harmonics, Flicker and Harmonics Immunity

EQUIPMENT	MANUFACTURER	MODEL NO.	SERIAL NO.
PROFLINE 2103-240 SINGLE PHASE 3KV SYSTEM	SCHAFFNER	PROFLINE: 2103-240-413 NSG: 1007-3-240-413 CCN: 1000-1	58396 AND 72614

Electro-Static Discharge

EQUIPMENT	MANUFACTURER	MODEL NO.	SERIAL NO.
ESD SIMULATOR	KIKUSUI	KES 4021	ME004852

EFT, Surge and Voltage Dip

EQUIPMENT	MANUFACTURER	MODEL NO.	SERIAL NO.
MULTIFUNCTION GENERATOR	SCHAFFNER	MODULA 6150	34586

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Radiated Immunity

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EQUIPMENT	MANUFACTURER	MODEL NO.	SERIAL NO.	
SIGNAL GENERATOR	R&S	SMB100A	100981	
RF AMPLIFIER	SCHAFFNER	CBA 9433	T43544	
ANTENNA X-WING BILOG TYPE	SCHAFFNER	CBL 6143	5123	
POWER METER	R&S	NRVD	102067	
Power Amplifier	MIILMEGA	AS0104-55_55	1029808	

Conducted Immunity

EQUIPMENT	MANUFACTURER	MODEL NO.	SERIAL NO.
SIGNAL GENERATOR	IFR	2023 A	202304/386
RF POWER AMPLIFIER	HAEFELY	PAMP 250	145611
M2 / M3 COUPLER	LUTHI	L-801 M2 / M3	2016

Remarks: -

N/A: Not Applicable or Not Available

The measurement instrumentation uncertainty would be taking into consideration on each of the test result



Test Results

Emission

Conducted Emissions (150kHz to 30MHz)

Test Requirement: EN 55022
Test Method: CISPR 22
Test Limits: Class B

Test Date(s): 2009-06-29

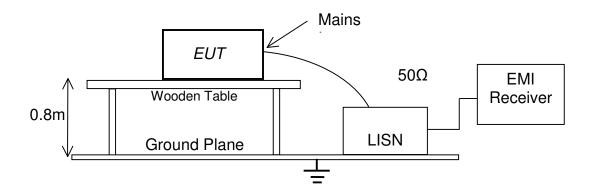
Mode of Operation: Program running mode (Connected to PC)

Test Method:

Initial measurements were performed in peak and average detection modes on the live line, any emissions recorded within 30dB of the relevant limit lines were remeasured using quasi-peak and average detection on the live and neutral lines with the worst case recorded in the table of results.

The test was performed in accordance with CISPR 22.

Test Setup:



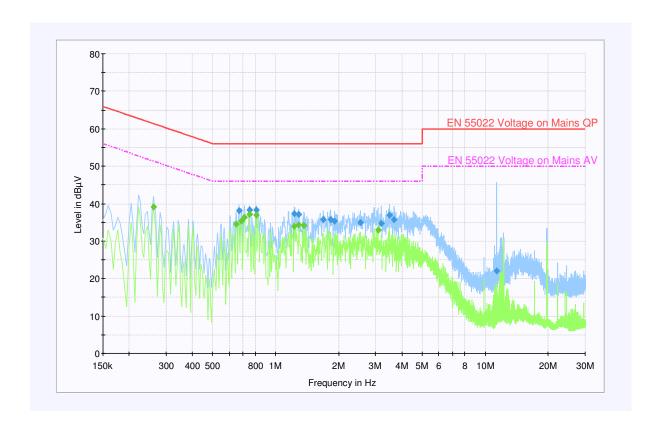


Measurement Data

Test Result of (Program running mode, connected to PC): PASS

Results and limit lines for Conducted Emission:

Limits for Conducted Emission Test, please refer to limit lines (Quasi-Peak and Average) in the following diagram.





Radiated Emissions (30MHz to 1GHz)

Test Requirement: EN 55022
Test Method: CISPR 22
Test Limits: Class B

Test Date(s): 2009-06-30

Mode of Program running mode (Connected to PC)

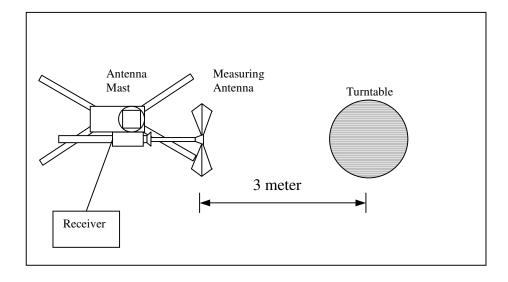
Operation:

Test Method:

Radiated emissions measurements are investigated and taken pursuant to the procedures of CISPR 22.

The equipment under test (EUT) was placed on a non-conductive turntable with dimensions of 1.5m x 1m and 0.8m high above the ground. 3m from the EUT, a broadband antenna mounting on the mast received the signal strength. The turntable was rotated to maximize the emission level. The antenna was then moving along the mast from 1m up to 4m until no more higher value was found. Both horizontal and vertical polarization of the antenna were placed and investigated.

Test Setup: Open Area Test Site





Measurement Data

Test Result of (Program running mode, connected to PC): PASS

Detection mode: Quasi-Peak

Frequency (MHz)	Polarity (H/V)	Field Strength at 3m (dBµV/m)	Limit at 3m (dBµV/m)	Margin (dB)
144.00	V	29.9	40.0	-10.1
192.00	Н	29.4	40.0	-10.6
216.04	V	25.1	40.0	-14.9
960.04	Н	34.7	47.0	-12.3
168.00	Н	23.0	40.0	-17.0

Note: Field Strength includes Antenna Factor and Cable Loss.



Harmonics Emissions on AC Supply

Test Requirement: EN 61000-3-2
Test Method: EN 61000-3-2
Classification / Limits: Class A

Test Date(s): 2009-06-30

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with EN 61000-3-2.



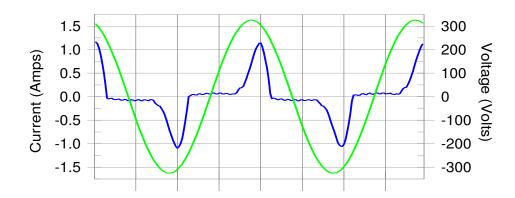
Measurement Data

Test Result of (Program running mode, connected to PC): PASS

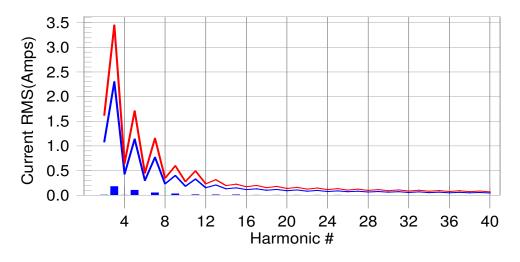
Results and limit line for Harmonics Emissions:

For limits for Harmonics Emission Test, please refer to limit lines (saw-tooth lines) in the following diagram.

Current & voltage waveforms



Harmonics and Class A limit line European Limits





Emission for Fluctuations & Flicker

Test Requirement: EN 61000-3-3

Test Method: EN 61000-3-3

Test Date(s): 2009-06-30

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with EN 61000-3-3.

Limits for Flicker:

Please refer to the result table for details.

Test Result of (Program running mode, connected to PC): PASS

Please refer to the following table for individual results.

Maximum Occurring Levels:

Pst:	0.064	Limit =	1.0	(The Highest Short Term Flicker Value)
Plt:	0.028	Limit =	0.65	(The Highest Long Term Flicker Value)
dc(%):	0.00	Limit =	3.3%	(The Highest Relative Steady State Voltage Change (1sec))
dmax(%):	0.00	Limit =	4%	(*The Highest Maximum Relative Voltage Change)
Tdt(mS):	0.0	Limit =	500ms	(The Max Time (mS) that dt exceeds 3.3%)
Ut(V):	230.00Va.c.			(EUT Test RMS Voltage)

Remarks:

* - Some products may have more relax limits (refer to Clause 5 of EN 61000-3-3)



Immunity

Susceptibility Performance Criteria

Α	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance
	which is self-recoverable
С	Temporary degradation or loss of function or performance
	which requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to damage of equipment (components) or software, or loss of data



Electrostatic Discharge

Test Requirement: EN 55024 Test Method: IEC 61000-4-2

Test Level: ±4kV for Direct & Indirect Contact Discharge

±8kV for Air Discharge

Performance Criterion Requirement: B

Temperature: 23.0 °C Humidity: 53.0 % Atmospheric 101.4 kPa

Pressure:

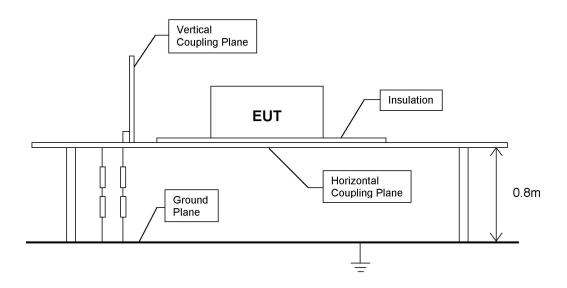
Test Date(s): 2009-06-30

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with IEC 61000-4-2.

Test Setup:





Test Levels for Electrostatic Discharge:

Level	Test Voltage Direct & Indirect Contact Discharge	Test Voltage Air Discharge
1	±2kV	±2kV
2	±4kV	±4kV
3	±6kV	±8kV
4	±8kV	±15kV

Test Result of (Program running mode, connected to PC): PASS

Please refer to the following table for individual results.

Logation		Discharge	Test	Individual Results	
Location		Method	Voltage	Pass	Failed
HCP	[Horizontal Coupling Plane]	Indirect Contact	±4kV	\boxtimes	
VCP [Vertical Coupling Plane]		Indirect Contact	±4kV	\boxtimes	
Enclosure		Air	±8kV	\boxtimes	
Metallic part		Direct Contact	±4kV	\boxtimes	



Electrical Fast Transients on AC Supply

Test Requirement: EN 55024 Test Method: EC 61000-4-4

Test Level: ±1kV

Performance Criterion Requirement: B

Temperature: 23.0 °C Humidity: 53.0 % Atmospheric 101.4 kPa

Pressure:

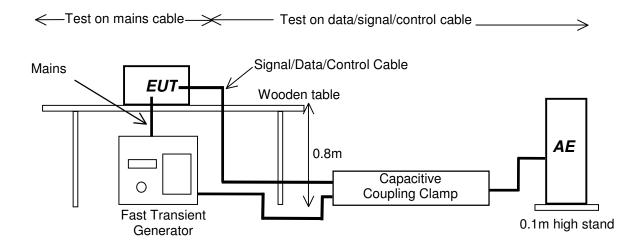
Test Date(s): 2009-06-29

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with IEC 61000-4-4.

Test Setup:





Test Levels for Electrical Fast Transient:

Level	On power su	pply port, PE	On I/O (Input/Output) signal, data and control ports		
	Voltage peak	Repetition rate	Voltage peak	Repetition rate	
	[kV]	[kHz]	[kV]	[kHz]	
1	0.5	5.0	0.25	5.0	
2	1.0	5.0	0.50	5.0	
3	2.0	5.0	1.00	5.0	
4	4.0	5.0	2.00	5.0	

Test Result of (Program running mode, connected to PC): PASS

Please refer to the following table for individual results

Conductor	Polarity &	Duration	Individual Results		
	Level	(s)	Pass	Failed	
Live – Neutral – Earth	±1kV	120			



Radiated Immunity (80MHz to 1000MHz)

Test Requirement: EN 55024 Test Method: IEC 61000-4-3

Test Level: 3V/m

Modulation: 80% 1kHz AM

Performance Criterion Requirement: A

Temperature: 22.0 °C Humidity: 55.0 % Atmospheric 101.1 kPa

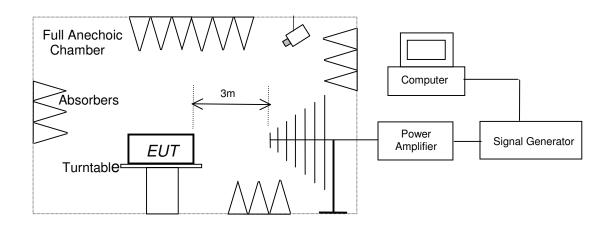
Pressure:

Test Date(s): 2009-06-27

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with IEC 61000-4-3.





Test Result of (Program running mode, connected to PC): PASS

Please refer to the following table for individual results.

Frequency (MHz)	Face	Polarity	Level (V/m)	Dwell Time		idual sults
				(s)	Pass	Failed
80-1000	0°	Horizontal / Vertical	3	3		
80-1000	90°	Horizontal / Vertical	3	3	\boxtimes	
80-1000	180°	Horizontal / Vertical	3	3	\boxtimes	
80-1000	270°	Horizontal / Vertical	3	3	\boxtimes	



Surge Immunity on AC Supply

Test Requirement: EN 55024 Test Method: IEC 61000-4-5

Test Level: ± 1.0 kV (between live & neutral)

±2.0kV (between live & earth) ±2.0kV (between neutral & earth)

Performance Criterion Requirement: B

Temperature: 23.0 °C Humidity: 53.0 % Atmospheric 101.4 kPa

Pressure:

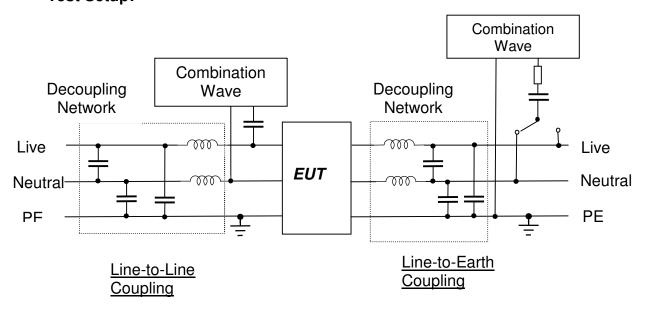
Test Date(s): 2009-06-29

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with IEC 61000-4-5.

Test Setup:





Test Levels for Surge Immunity:

Level	Open-circuit test voltage ±10%
1	0.5 kV
2	1.0 kV
3	2.0 kV
4	4.0 kV

Test Result of (Program running mode, connected to PC): PASS

Please refer to the following table for individual results.

Conductor	Level & Polarity	No. of Surge	Phase Angle	Surge Interval		idual sults
		_	_		Pass	Failed
			0°			
Live Neutral	14.014	E	90°	600	\boxtimes	
Live - Neutral	±1.0kV	5	180°	60s	\boxtimes	
			270°		\boxtimes	
			0°		\boxtimes	
Live - Earth	±2.0kV	5	90°	60s	\boxtimes	
Live - Earth			180°		\boxtimes	
			270°		\boxtimes	
			0°		\boxtimes	
Neutral - Earth	±2.0kV	_	90°	60s	\boxtimes	
		5	180°			
			270°		\boxtimes	



Continuous RF Immunity on AC Supply (150kHz to 80MHz)

Test Requirement: EN 55024 Test Method: IEC 61000-4-6

Test Level: 3Vrms(emf) with 80% 1kHz AM

Performance Criterion Requirement: A

Temperature: 23.0 °C Humidity: 55.0 % Atmospheric 101.7 kPa

Pressure:

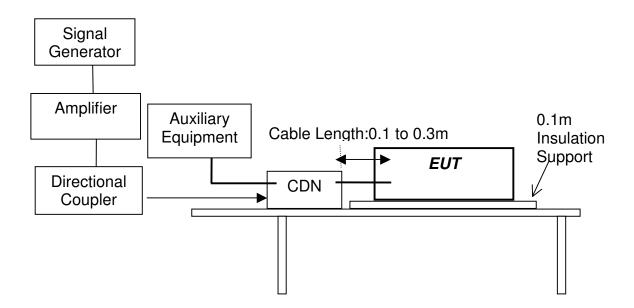
Test Date(s): 2009-07-01

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with IEC 61000-4-6.

Test Setup:





Test Levels for Continuous RF Immunity:

Frequency range 150kHz - 80MHz				
Level	Level Voltage level (emf)			
$U_{o}\left[dB(\muV)\right] \qquad \qquad U_{o}\left[V\right]$				
1	120	1		
2	130	3		
3	140	10		

Test Result of (Program running mode, connected to PC): PASS

Please refer to the following table for individual results.

Frequency (MHz)	Level (Vrms)	Dwell Time (s)	Sweep rate (%)	Individual Results	
				Pass	Failed
0.15 – 80	3.0	3	1	\boxtimes	



Voltage Dips, Interruptions and Variations on AC Supply

Test Requirement: EN 55024
Test Method: IEC 61000-4-11

Test Level: [0, 0, 70]% of U_T

Temperature: 23.0 °C Humidity: 53.0 % Atmospheric 101.4 kPa

Pressure:

Test Date(s): 2009-06-29

Mode of Operation: Program running mode (Connected to PC)

Test Method:

The test was performed in accordance with IEC 61000-4-11.

Test Levels for voltage dips, short interruptions and voltage variations

immunity:

Test Level (% of U _T)	Voltage dip and short interruptions (%)	Duration (period)	Performance Criterion
0	100	0.5	В
0	100	250	С
70	30	25	С

Test Result of (Program running mode, connected to PC): PASS

Please refer to the following table for individual results.

Phase	Test Level (% of U _T)	Duration (period)	Individual Results	
			Pass	Failed
0° followed by 180°	0	0.5		
0° followed by 180°	0	250		
0° followed by 180°	70	25		

***** End of Test Report *****

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